

Notice of References Cited	Application/Control No. 10/543,193		Applicant(s)/Patent Under Reexamination HIRASHIMA ET AL.	
	Examiner Lei Yao, Ph.D.		Art Unit 1642	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,027,916	02-2000	Ni et al.	435/69.1
	B	US-			
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	D	US-			
	E	US-			
	F	US-			
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FOREIGN PATENT DOCUMENTS

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	N					
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NON-PATENT DOCUMENTS

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